

Search Notes

Application/Control No.

10/046,314

Examiner

John B. Walsh

Applicant(s)/Patent under
Reexamination

VION-DURY ET AL.

Art Unit

2151

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
text search (see separate sheet)	9/24/05	SW